

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination VAN GINNEKEN, LUKAS P.P.	
		Examiner Vuthe Siek	Art Unit 2825	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kannan et al., "A Methodology and Algorithms for Post-Placement Delay Optimization," ACM, 31st ACM/IEEE Design Automation Conference, 1994, pp. 327-332.
	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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